


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/624,114	SCHICK ET AL.	
	Examiner	Art Unit	
	Ted Kim	3746	

SEARCHED			
Class	Subclass	Date	Examiner
60	784		
	39.12		
	39.38		
	39.76	4/11/2006	TK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East (attached)	4/11/2006	TK

7